

Notic of References Cited	Application/Control No. 10/707,500		Applicant(s)/Patent Under Reexamination AOKI ET AL.	
	Examiner Jinhee J Lee		Art Unit 2831	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,105,216 A	08-2000	Oppperthausen, Orval A.	24/459
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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	I	US-			
	J	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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